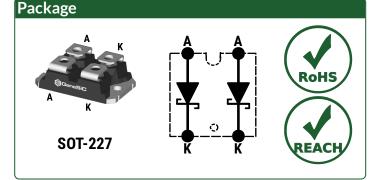
Silicon Carbide Schottky Diode



V _{RRM} =	650 V
I F(T _C = 75°C) =	300 A *
Qc =	446 nC *

Features

- Gen4 Thin Chip Technology for Low VF
- Superior Figure of Merit Q_C/I_F
- 100% Avalanche Tested
- Enhanced Surge Current Robustness
- Temperature Independent Fast Switching
- Low Thermal Resistance
- Positive Temperature Coefficient of VF
- High dV/dt Ruggedness



Advantages

- Optimal Price Performance
- Improved System Efficiency
- Reduced Cooling Requirements
- Increased System Power Density
- Zero Reverse Recovery Current
- High System Reliability
- Easy to Parallel without Thermal Runaway
- Enables Extremely Fast Switching

Applications

- EV Fast Chargers
- Solar Inverters
- Switched Mode Power Supply (SMPS)
- High frequency Converters
- Motor Drives
- Induction Heating and Welding
- Uninterruptible Power Supply (UPS)
- Pulsed Power

Absolute Maximum Ratings (At T_c = 25°C Unless Otherwise Stated)

Parameter	Symbol	Conditions	Values	Unit	Note
Repetitive Peak Reverse Voltage (Per Leg)	V _{RRM}		650	V	
		T _C = 75°C, D = 1	150 / 300		
Continuous Forward Current (Per Leg / Per Device)	IF	T _C = 100°C, D = 1	125 / 250	A	Fig. 4
		T _C = 75°C, D = 1	150 / 300		
Non-Repetitive Peak Forward Surge Current, Half Sine	Irou	T _C = 25°C, t _P = 10 ms	1050	٨	
Wave (Per Leg)	IF,SM	T _C = 150°C, t _P = 10 ms	840	A	
Repetitive Peak Forward Surge Current, Half Sine Wave	I _{ERM}	T _C = 25°C, t _P = 10 ms	630	А	
(Per Leg)	IF,RM	T _C = 150°C, t _P = 10 ms	440	A	
Non-Repetitive Peak Forward Surge Current (Per Leg)	I _{F,MAX}	T _C = 25°C, t _P = 10 μs	5250	А	
i ² t Value (Per Leg)	∫i²dt	T_{C} = 25°C, t_{P} = 10 ms	5512	A ² s	
Non-Repetitive Avalanche Energy (Per Leg)	E _{AS}	L = 0.1 mH, I _{AS} = 150 A	1333	mJ	
Diode Ruggedness (Per Leg)	dV/dt	V _R = 0 ~ 520 V	200	V/ns	
Power Dissipation (Per Leg / Per Device)	Ртот	T _C = 25°C	406 / 812	W	Fig. 3
Operating and Storage Temperature	Tj, Tstg		-55 to 175	°C	

* Per Device

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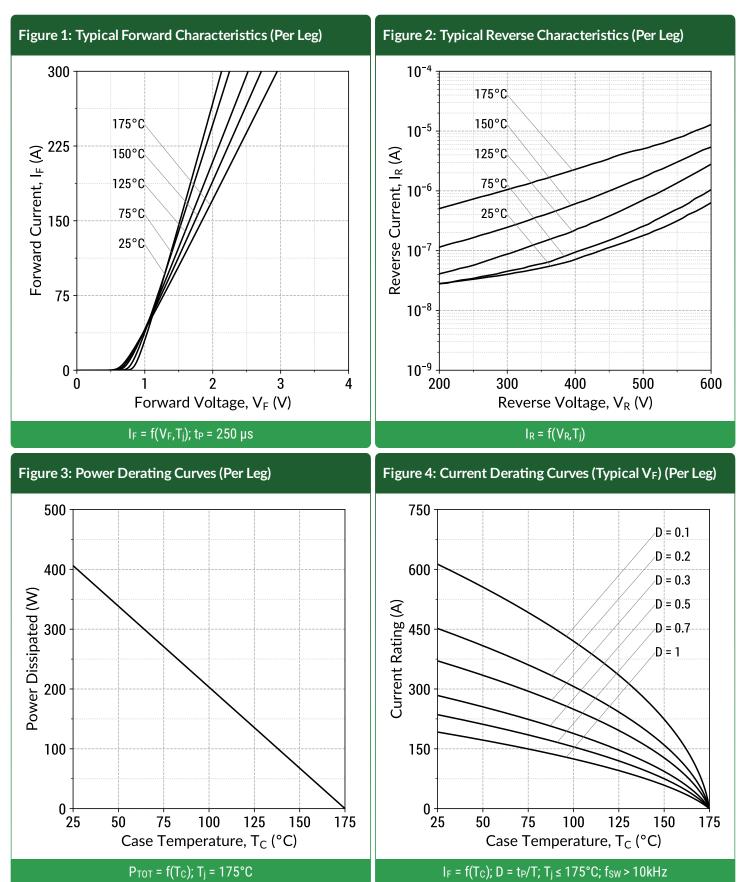


Electrical Characteristics (Per Leg) Values Parameter Symbol Conditions Note Unit Min. Тур. Max. I_F = 150 A, T_i = 25°C 1.5 1.8 ۷ Diode Forward Voltage V_{F} Fig. 1 I_F = 150 A, T_j = 175°C 1.8 V_R = 650 V, T_i = 25°C 1 10 **Reverse Current** Fig. 2 IR μA V_R = 650 V, T_j = 175°C 25 V_R = 200 V 152 **Total Capacitive Charge** Qc nC Fig. 7 V_R = 400 V 223 I_F ≤ I_{F,MAX} $dI_F/dt = 200 A/\mu s$ V_R = 200 V Switching Time < 10 ts ns V_R = 400 V V_R = 1 V, f = 1MHz 3560 С **Total Capacitance** рF Fig. 6 V_R = 400 V, f = 1MHz 305

Thermal/Package Characteristics

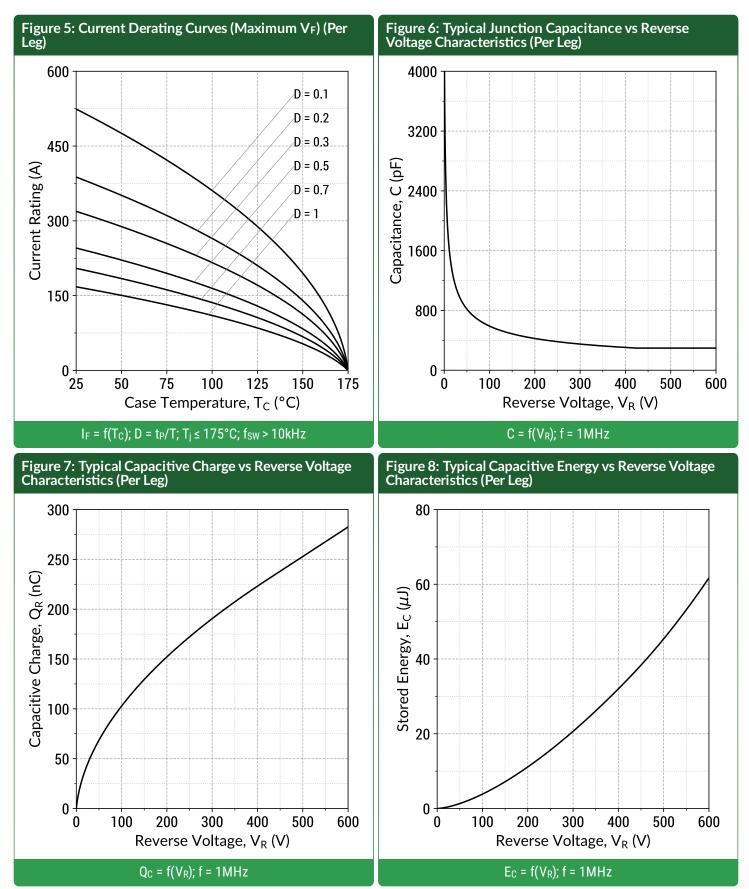
Parameter	Symbol	Conditions	Values			11	Note
		Conditions	Min.	Тур.	Max.	- Unit	Note
Thermal Resistance, Junction - Case (Per Leg)	RthJC			0.37		°C/W	Fig. 9
Weight	WT			28.0		g	
Mounting Torque	T _M	Screws to Heatsink			1.5	Nm	-
Terminal Connection Torque	Tc	M4 Screws			1.3	Nm	-
Isolation Voltage(RMS)	V _{ISO} t = 1s (50/60 Hz) t = 60s (50/60 Hz)	t = 1s (50/60 Hz)		3000		V	
		t = 60s (50/60 Hz)		2500		v	
Creepage Distance on Surface	d _{Ctt}	Terminal to Terminal		10.5		mm	
	dctb	Terminal to Backside		8.5		mm	
Striking Distance Through Air	dstt	Terminal to Terminal		3.2		mm	
	d _{Stb}	Terminal to Backside		6.8		mm	



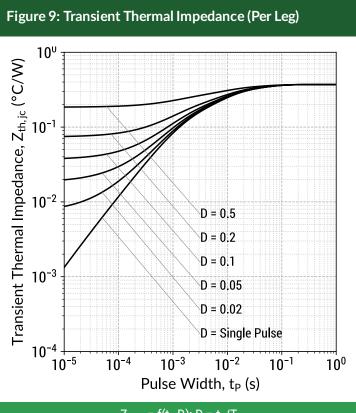


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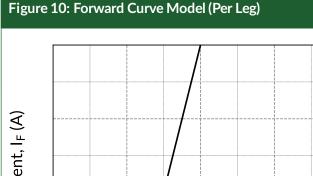




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 $Z_{th,jc} = f(t_P,D); D = t_P/T$



Forward Current, I_F (A) 1/RDIFF VBI \ Forward Voltage, V_F (V) $I_F = f(V_F, T_j)$

	-		
Eonword	Curva	Madal	Equation:
FUIWalu	Curver	viouei	Equation.

 $I_F = (V_F - V_{BI})/R_{DIFF} (A)$

Built-In Voltage (V_{BI}):

 $V_{BI}(T_i) = m \times T_i + n (V)$ m = -0.00114 (V/°C)n = 0.931 (V)

Differential Resistance (RDIFF):

 $R_{DIFF}(T_i) = a \times T_i^2 + b \times T_i + c(\Omega)$ a = $1.05e-07 (\Omega/^{\circ}C^{2})$ **b** = 1.12e-06 (Ω /°C) **c** = 0.00401 (Ω)

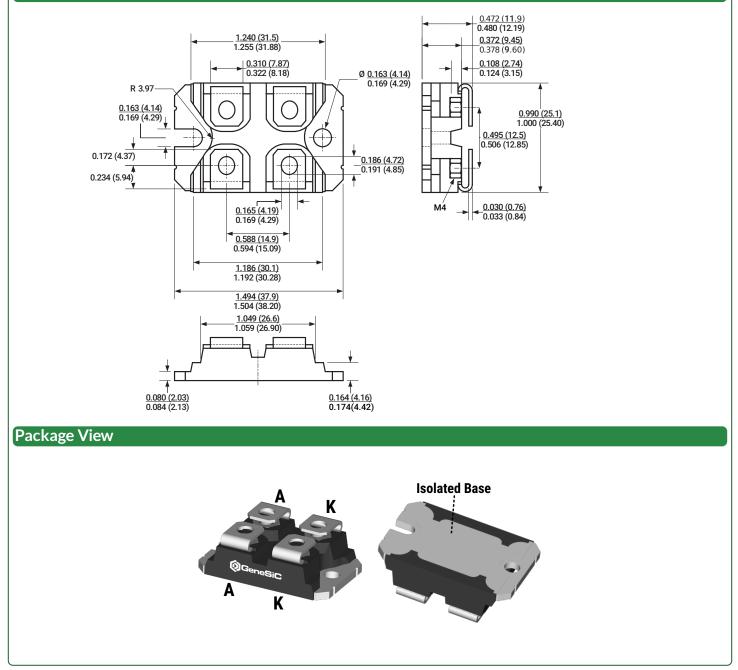
Forward Power Loss Equation:

 $P_{LOSS} = V_{BI}(T_i) \times I_{AVG} + R_{DIFF}(T_i) \times I_{RMS}^2$



Package Dimensions

SOT-227 Package Outline



NOTE

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.



Compliance

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

REACH Compliance

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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Related Links

SPICE Models:	https://www.genesicsemi.com/sic-schottky-mps/GD2X150MPS06N/GD2X150MPS06N_SPICE.zip
• PLECS Models:	https://www.genesicsemi.com/sic-schottky-mps/GD2X150MPS06N/GD2X150MPS06N_PLECS.zip
CAD Models:	https://www.genesicsemi.com/sic-schottky-mps/GD2X150MPS06N/GD2X150MPS06N_3D.zip
• Evaluation Boards	s: https://www.genesicsemi.com/technical-support
Reliability:	https://www.genesicsemi.com/reliability
Compliance:	https://www.genesicsemi.com/compliance
• Quality Manual:	https://www.genesicsemi.com/quality

Revision History

Rev 22/May: Initial Release



www.genesicsemi.com/sic-schottky-mps/



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